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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/751,632	TOHMA ET AL.	IA ET AL.
Examiner	Art Unit	it
Bumsuk Won	2879	

	SEARCHED			
Class	Subclass	Date	Examiner	
313	512	8/29/2005	BWON	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Consulted Mariceli Santiago (AU 2879) for classification search, 313/512,511,504,503,509	8/29/2005	BWON
text search (electroluminescent, electrode, layer, color, filter, passivation, sealing, encapsulation, planarizing)	8/29/2005	BWON
text search (above + film, coat, laminate, tft)	8/29/2005	BWON
citation search, Yamazaki, US 6,689,492	8/29/2005	BWON